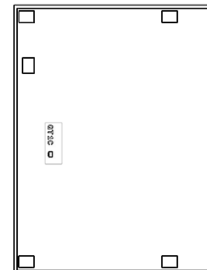
MMIC

Directional Coupler Die

EDC10-273-D+

50Ω 10dB 6 to 26.5 GHz



The Big Deal

- Wideband, 6-26.5 GHz
- Excellent coupling flatness 10±1.5 dB typ.
- Highly repeatable performance (GaAs based design)

Product Overview

Mini-Circuits' EDC10-273-D+ is a 10 dB directional coupler die that operates from 6 to 26.5 GHz. It provides excellent coupling flatness over a broad bandwidth and good return loss. This coupler also provides a quadrature phase shift between the signal at the through port and coupler port. Manufacturing using GaAs Technology, this model results in relatively high repeatablility in performance.

Key Features

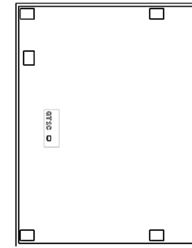
Feature	Advantages
Wideband, 6 to 26.5 GHz	EDC10-273-D+ can be used in many applications, saving component count. Also ideal for wideband applications such as military and instrumentation.
Excellent coupling flatness	Excellent coupling flatness yields higher accuracy.
Unpackaged die	Enables user to integrate it directly into hybrids.

MMIC

Directional Coupler Die

EDC10-273-D+

50Ω 10dB 6 to 26.5 GHz



Product Features

- Wideband, 6-26.5 GHz
- Excellent coupling flatness 10±1.5 dB typ.
- Highly repeatable performance (GaAs based design)

+RoHS Compliant
The +Suffix identifies RoHS Compliance. See our web site for RoHS Compliance methodologies and qualifications

Ordering Information: Refer to Last Page

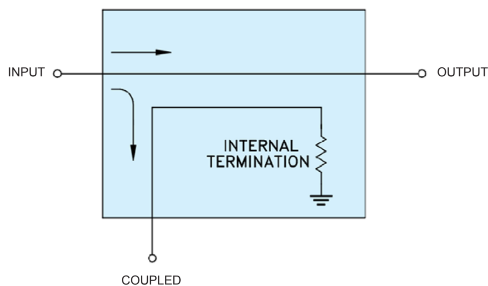
Typical Applications

- Satellite communications
- Wireless infrastructure
- Test and Measurements

General Description

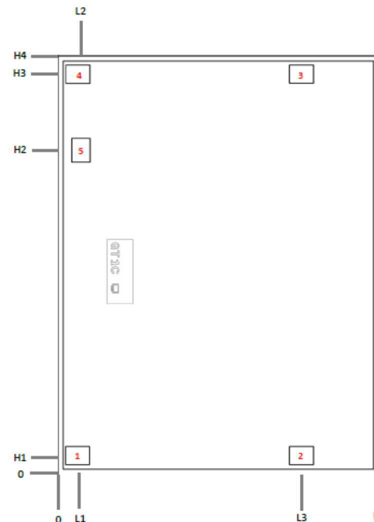
Mini-Circuits' EDC10-273-D+ is a 10 dB directional coupler die that operates from 6 to 26.5 GHz. It provides excellent coupling flatness over a broad bandwidth and good return loss. This coupler also provides a quadrature phase shift between the signal at the through port and coupler port. Manufacturing using GaAs Technology, this model results in relativerly high repeatablility in performance.

Simplified Schematic and Pad description



Pad#	Function
1	Coupled
2	Input
3	Output
4	Isolated
5	Termination
Die Bottom	Ground

Bonding Pad Position



Die dimensions in µm

L1	L2	L3	L4	H1	H2	H3	H4
112	129	1484	1950	104	1980	2446	2550
Thickness		Die size		Bond pad #1, #2, #3 & #4 Size		Bond pad #5 Size	
100		1950 x 2550		142 x 107		107 x 142	

Electrical Specifications[1] at 25°C

Parameter	Frequency (MHz)	Min.	Typ.	Max.	Unit
Frequency Range		6000		26500	MHz
Mainline Loss	6000 - 10000		1.0		dB
	10000 - 18000		1.4		
	18000 - 23000		1.5		
	23000 - 26500		1.8		
Nominal Coupling	6000 - 10000		10.3		dB
	10000 - 18000		10.4		
	18000 - 23000		11.4		
	23000 - 26500		10.1		
Coupling Flatness(±)	6000 - 26500		1.5		dB
Directivity	6000 - 10000		16		dB
	10000 - 18000		15		
	18000 - 23000		14		
	23000 - 26500		11		
Return Loss (Input)	6000 - 10000		24		dB
	10000 - 18000		17		
	18000 - 23000		15		
	23000 - 26500		15		
Return Loss (Output)	6000 - 10000		22		dB
	10000 - 18000		16		
	18000 - 23000		16		
	23000 - 26500		19		
Return Loss (Coupled)	6000 - 10000		24		dB
	10000 - 18000		16		
	18000 - 23000		14		
	23000 - 26500		14		

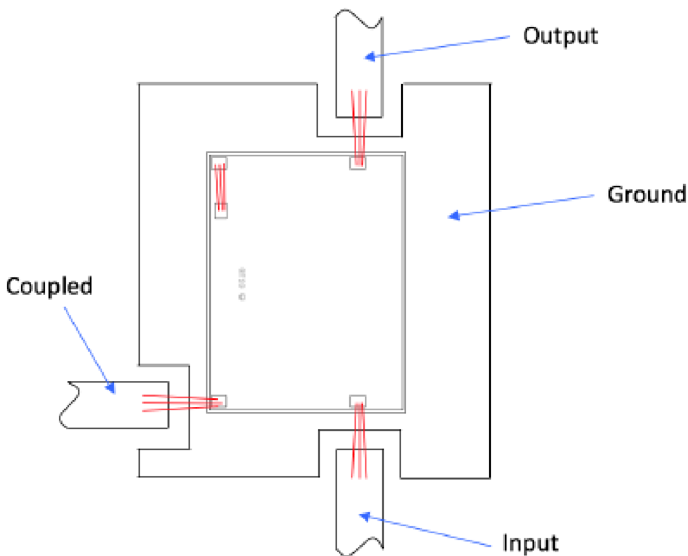
1. Measured on Mini-Circuits Characterization test board. Die is packaged in 4x4mm 24-lead MCLP package and soldered on TB-EDC10-273+.

Absolute Maximum Ratings[2]

Parameter	Ratings
Operating Temperature	-40°C to 85°C
Input Power	28 dBm (5 minute max.) 25 dBm (continuous)
Power at internal termination	19 dBm (5 minute max.) 16 dBm (continuous)

2. Permanent damage may occur if any of these limits are exceeded.
Electrical maximum ratings are not intended for continuous normal operation.

Assembly Diagram



Assembly and Handling Procedure

1. Storage
   Dice should be stored in a dry nitrogen purged desiccators or equivalent.
2. ESD
   MMIC coupler dice are susceptible to electrostatic and mechanical damage. Die are supplied in antistatic protected material, which should be opened in clean room conditions at an appropriately grounded anti-static worksta tion. Devices need careful handling using correctly designed collets, vacuum pickup tips or sharp antistatic tweezers to deter ESD damage to dice.
3. Die Attach
   The die mounting surface must be clean and flat. Using conductive silver filled epoxy, recommended epoxies are DieMat DM6030HK-PT/H579 or Ablestik 84-1LMISR4. Apply sufficient epoxy to meet required epoxy bond line thickness, epoxy fillet height and epoxy coverage around total die periphery. Parts shall be cured in a nitrogen filled atmosphere per manufacturer's cure condition. It is recommended to use antistatic die pick up tools only.
4. Wire Bonding
   Bond pad openings in the surface passivation above the bond pads are provided to allow wire bonding to the dice gold bond pads. Thermosonic bonding is used with minimized ultrasonic content. Bond force, time, ultrasonic power and temperature are all critical parameters. Suggested wire is pure gold, 1 mil diameter. Bonds must be made from the bond pads on the die to the package or substrate. All bond wires should be kept as short as low as reasonable to minimize performance degradation due to undesirable series inductance.

Additional Detailed Technical Information *additional information is available on our dash board.*	
Performance Data	Data Table
	Swept Graphs
	S-Parameter (S3P Files)
Case Style	Die
Die Ordering and packaging information (Note 5)	Quantity, Package — Model No. Small, Gel - Pak: 5,10,50, KGD* — EDC10-273-DG+ Medium†, Partial wafer: KGD*<455 — EDC10-273-DP+ Large†, Full wafer — EDC10-273-DF+ **†Available upon request contact sales representative** Refer to AN-60-067
Environmental Ratings	ENV-80

*Known Good Dice (“KGD”) means that the dice are taken from PCM good wafer and visually inspected in question have been subjected to Mini-Circuits while this is not definitive, it does help to provide a higher degree of confidence that dice are capable of meeting typical RF electrical parameters specified by Mini-Circuits.

ESD Rating**

Human Body Model (HBM): Class 1B (500V) in accordance with ANSI/ESD STM 5.1 - 2001

** Tested in industry standard 4x4 mm, 24-lead MCLP package.

Additional Notes

A. Performance and quality attributes and conditions not expressly stated in this specification document are intended to be excluded and do not form a part of this specification document.

B. Electrical specifications and performance data contained in this specification document are based on Mini-Circuit’s applicable established test performance criteria and measurement instructions.

C. The parts covered by this specification document are subject to Mini-Circuits standard limited warranty and terms and conditions (collectively, “Standard Terms”); Purchasers of this part are entitled to the rights and benefits contained therein. For a full statement of the Standard Terms and the exclusive rights and remedies thereunder, please visit Mini-Circuits’ website at www.minicircuits.com/MCLStore/terms.jsp

D. Mini-Circuits does not warrant the accuracy or completeness of the information, text, graphics and other items contained within this document and same are provided as an accommodation and on an “As is” basis, with all faults.

E. Purchasers of this part are solely responsible for proper storing, handling, assembly and processing of Known Good Dice (including, without limitation, proper ESD preventative measures, die preparation, die attach, wire bond ing and related assembly and test activities), and Mini-Circuits assumes no responsibility therefor or for environmental effects on Known Good Dice.

F. Mini-Circuits and the Mini-Circuits logo are registered trademarks of Scientific Components Corporation d/b/a Mini-Circuits. All other third-party trademarks are the property of their respective owners. A reference to any third-party trademark does not constitute or imply any endorsement, affiliation, sponsorship, or recommendation by any such third-party of Mini-Circuits or its products.